

Notice of References Cited

Application/Control No.

10/566,997

Applicant(s)/Patent Under

Reexamination

HECKMEIER ET AL.

Examiner

Shean C. Wu

Art Unit

1795

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,622,165	11-2009	Wittek et al.	428/1.1
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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